

TMA 4275 Lifetime analysis

Exercise 3 - solution

Problem 1

Basic statics: Stats > Basic Statistics > Display Descriptive Statistics

Variable	N	N*	Mean	SE Mean	StDev	Minimum	Q1	Median	Q3	Maximum
C1	12	0	40.16	9.22	31.95	0.80	13.48	31.00	68.40	96.00

Histogram: Graph > Histogram

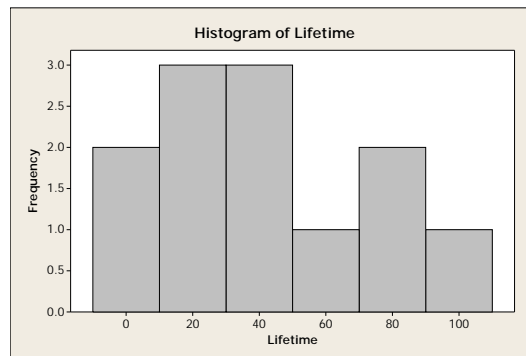


Figure 1: Histogram of lifetime

Empirical cumulative distribution function: Graph > Empirical CDF

Kaplan-Meier estimator: Stats > Reliability/Survival > Distribution Analysis (Right censoring) > Nonparametric Distribution Analysis

Distribution Analysis: Lifetime

Variable: Lifetime

Censoring Information	Count
Uncensored value	12

Nonparametric Estimates

Characteristics of Variable

	Standard	95.0% Normal CI	
Mean(MTTF)	Error	Lower	Upper
40.1583	9.22398	22.0797	58.2370

Median = 30.4

IQR = 43.8 Q1 = 10.2 Q3 = 54

Kaplan-Meier Estimates

Time	Number at Risk	Number Failed	Survival Probability	Standard Error	95.0% Normal CI	
					Lower	Upper
0.8	12	1	0.916667	0.079786	0.760290	1.00000
3.6	11	1	0.833333	0.107583	0.622475	1.00000
10.2	10	1	0.750000	0.125000	0.505005	0.99500
23.3	9	1	0.666667	0.136083	0.399949	0.93338
28.0	8	1	0.583333	0.142319	0.304394	0.86227
30.4	7	1	0.500000	0.144338	0.217104	0.78290
31.6	6	1	0.416667	0.142319	0.137727	0.69561
41.2	5	1	0.333333	0.136083	0.066616	0.60005
54.0	4	1	0.250000	0.125000	0.005005	0.49500
73.2	3	1	0.166667	0.107583	0.000000	0.37753
89.6	2	1	0.083333	0.079786	0.000000	0.23971
96.0	1	1	0.000000	0.000000	0.000000	0.00000

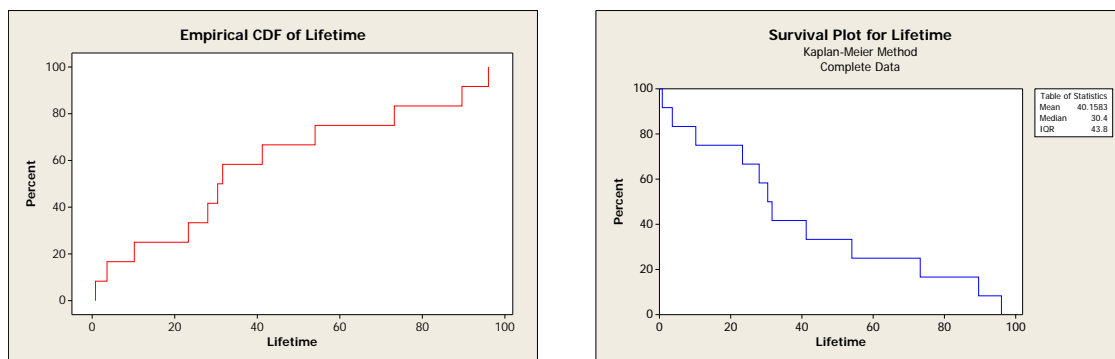


Figure 2: Empirical cumulative distribution function and Kaplan Meier estimator

Parametric fit overview plot: Stats > Reliability/Survival > Distribution Analysis
(Right censoring) > Distribution Overview plot

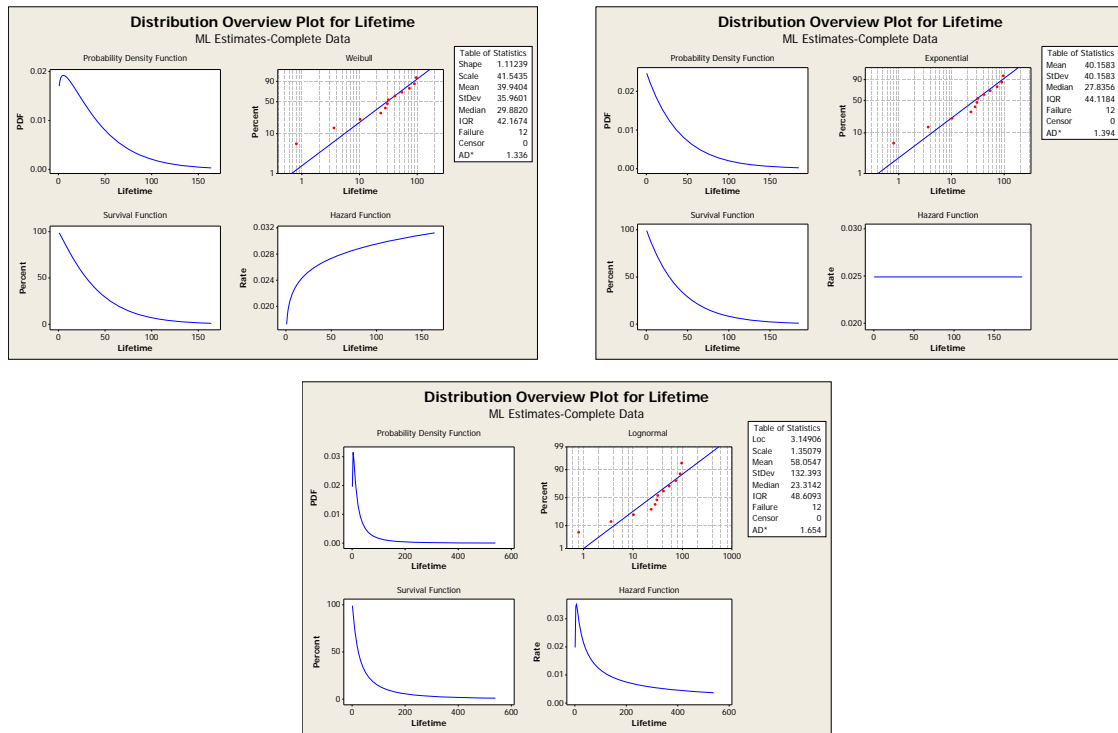


Figure 3: Distribution overview plots for Weibull, exponential and log-normal distribution. Based on the probability plots, the Weibull distribution and the exponential distribution seems to be more appropriate than the lognormal distribution

Problem 2

For the non-censored data, the empirical survival plot obtained by the Kaplan-Meier method is $1 - (\text{empirical cumulative distribution function})$.

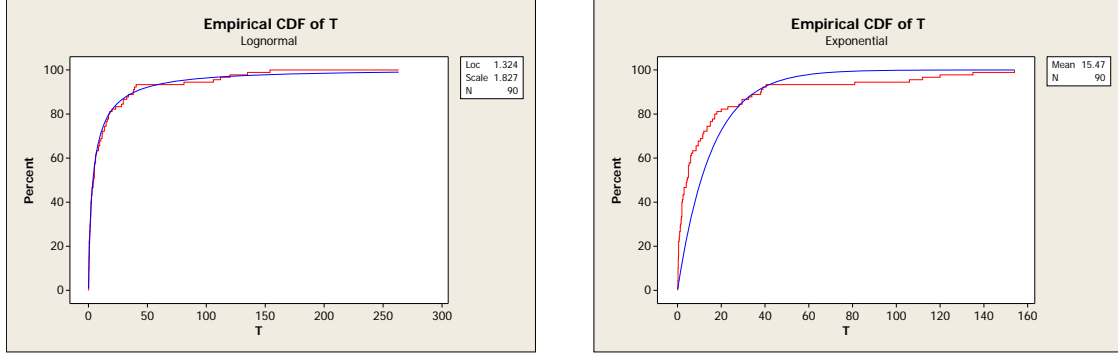


Figure 4: Empirical cumulative distribution function with the estimated curves for the log-normal distribution and exponential distribution. These plots indicates that log-normal distribution is better fit than exponential distribution.

Problem 3

a)

$$\begin{aligned} R_Z(z) &= P(Z > z) = P(T > z \cap V > z) = P(T > z)P(V > z) \\ &= R_T(z)R_V(z) = e^{-\lambda z}e^{-\mu z} = e^{-(\lambda+\mu)z} \end{aligned}$$

which is the reliability function of the exponential distribution with failure rate $\lambda + \mu$.

b) A serial system fails when there is a failure of any of the components of the system. That is, the lifetime is $Z = \min(T, V)$ with distribution as in a).

The probability that component A is the failure cause can be computed as

$$\begin{aligned} P(\text{failure due to the } A) &= P(V > T) = \int_0^{\infty} P(V > T | T = z) f_T(z) dz \\ &= \int_0^{\infty} P(V > z) f_T(z) dz = \int_0^{\infty} e^{-\mu z} \lambda e^{-\lambda z} dz \\ &= \frac{\lambda}{\lambda + \mu} \end{aligned}$$

c)

$$R(t) = 1 - P(T \leq t \cap V \leq t) = 1 - P(T \leq t)P(V \leq t) = 1 - (1 - e^{-\lambda t})(1 - e^{-\mu t})$$

d) Let T_{AB} be the time until failure of the system. Then

$$T_{AB} = T + V$$

The MTTF is given by

$$E(T_{AB}) = E(T) + E(V) = \frac{1}{\lambda} + \frac{1}{\mu}$$

and the survival function of the system

$$\begin{aligned} R(t) &= P(T_{AB} > t) = \int_0^t P(T_{AB} > t | T = z) f_T(z) dz \\ &= \int_0^t P(T_{AB} > t) f_T(z) dz + \int_t^\infty f_T(z) dz \\ &= \int_0^t P(T + V > t | T = z) f_T(z) dz + R_T(t) = \int_0^t P(V > t - z) f_T(z) dz + R_T(t) \\ &= \int_0^t \exp(-\mu(t - z)) \lambda \exp(-\lambda z) dz + \exp(-\lambda t) \\ &= \lambda \exp(-\mu t) \int_0^t \exp(z(\mu - \lambda)) dz + \exp(-\lambda t) \\ &= \lambda \exp(-\mu t) \frac{\exp(t(\mu - \lambda)) - 1}{\mu - \lambda} + \exp(-\lambda t) = \frac{\lambda}{\mu - \lambda} (\exp(-\lambda t) - \exp(-\mu t)) + \exp(-\lambda t) \\ &= \left(\frac{\lambda}{\mu - \lambda} - 1 \right) \exp(-\lambda t) - \frac{\lambda}{\mu - \lambda} \exp(-\mu t) = \frac{\mu}{\mu - \lambda} \exp(-\lambda t) - \frac{\lambda}{\mu - \lambda} \exp(-\mu t) \end{aligned}$$

Because $P(T_{AB} > t | T = z) = 1$ for $z > t$.

If $\mu = \lambda$ we can go back to the 5-th line of the above equation and replace μ with λ (or we can take the limit of the last part of the 7-th line and use L'Hospital's rule). The result is then:

$$\begin{aligned} &\lambda \exp(-\lambda t) \int_0^t \exp(z(\lambda - \lambda)) dz + \exp(-\lambda t) \\ &= \lambda \exp(-\lambda t) \int_0^t 1 dz + \exp(-\lambda t) \\ &= \lambda t \exp(-\lambda t) + \exp(-\lambda t) = \exp(-\lambda t)(1 + \lambda t) \end{aligned}$$

Which is the Gamma distribution.